| Search Notes | | | |
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| Application/Control No. | Applicant(s)/Patent under Reexamination |
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| 09/853,080 | LAUB ET AL. |
| Examiner | Art Unit |
| Patrick J. Nolan | 1644 |

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| Class | Subclass | Date | Examiner | |
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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | |
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